

PATENT

Docket No.: 67161-115

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of : Customer Number: 20277
Shoji ISHIDA : Confirmation Number:
Serial No.: : Group Art Unit:
Filed: October 10, 2003 : Examiner:
For: SEMICONDUCTOR MANUFACTURING APPARATUS ENABLING INSPECTION OF
MASS FLOW CONTROLLER MAINTAINING CONNECTION THERETO

INFORMATION DISCLOSURE STATEMENT

Mail Stop IDS
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

The relevance of each of the six references listed on the attached Form 1449, is discussed in the present specification.

Serial No.:

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

MCDERMOTT, WILL & EMERY


Stephen A. Becker
Registration No. 26,527

600 13th Street, N.W.
Washington, DC 20005-3096
(202) 756-8000 SAB:gav
Facsimile: (202) 756-8087
Date: October 10, 2003

INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)			ATTY. DOCKET NO. 67161-115	SERIAL NO. [case_serial_number]		
			APPLICANT Shoji ISHIDA			
			FILING DATE October 10, 2003	GROUP [case_group_art]		
U.S. PATENT DOCUMENTS						
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code ₂ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear		
		US				
		US				
		US				
		US				
		US				
		US				
		US				
		US				
FOREIGN PATENT DOCUMENTS						
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes-Number + Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document Pages, Columns, Lines Where Relevant Figures Appear	Translation	
					Yes	No
		JP 11-223538A	08/17/1999	CKD CORP.	JAPAN (w/English Abstract)	
		JP 7-134052A	05/23/1995	NEC CORP.	JAPAN (w/English Abstract)	
		JP 6-119059A	04/28/1994	CKD CORP.	JAPAN (w/English Abstract)	
		JP 6-41759A	02/15/1994	KOMATSU DENSHI KINZOKU KK	JAPAN (w/English Abstract)	
		JP 6-53103A	02/25/1994	HITACHI LTD.	JAPAN (w/English Abstract)	
		JP 5-108167A	04/30/1993	MITSUBISHI ELECTRIC CORP	JAPAN (w/English Abstract)	
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.				
EXAMINER			DATE CONSIDERED			

[REDACTED] agrees with MPEP 609. Draw line through citation if not in conformance and not considered.

*EXAMINER: Initial if reference considered, whether or not cited

***EXAMINER:** Initial if reference considered.
Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English is not his/her primary language.